

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under
Reexamination
CHEN ET AL.

Examiner

GERMAN VIANA DI PRISCO

Art Unit

2617

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0148780 A1	08-2003	Takano, Michiaki	455/522
	B	US-			
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FOREIGN PATENT DOCUMENTS

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